

2. It is hereby certified:

☐ that each item of information contained in this Information Disclosure Statement was cited in a communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of the Statement, or

☐ that no item of information contained in the Information Disclosure Statement was cited in a communication from a foreign patent office in a counterpart foreign application or, to the knowledge of the person signing the certification after making reasonable inquiry, was known to any individual designated in § 1.56 (c) more than three months prior to the filing of the Statement.

3. ☐ Consideration of the following additional information (including any co-pending or abandoned U.S. applications, prior uses and/or sales, etc.) is requested:

4. For each non-English language reference listed on the attached Form PTO-1449:

☐ reference is made to an English language translation submitted herewith, and/or

☐ reference is made to a foreign patent office search report (in the English language) submitted herewith, and/or

☐ reference is made to an English language translation of a foreign patent office search report submitted herewith, and/or

☐ reference is made to the concise explanation contained in the specification of the present application at page(s) _____, and/or

☐ reference is made to the concise explanation set forth below:

5. ☐ Applicant also offers the following comments for the Examiner's consideration:

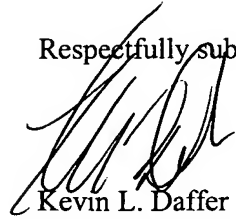
6. ☐ Also enclosed is a copy of a foreign search report citing these references.

7. ☐ The listed documents were brought to the attention of the Applicant(s) after payment of the issue fee in the captioned case. The documents were cited in a communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of this Information Disclosure Statement. Applicant(s) request this Information Disclosure Statement and attached Form PTO-1449 be placed in the file of the captioned application.

8. ☐ Applicant(s) requests that the Information Disclosure Statement and attached Form PTO-1449 and references, which are being filed before the grant of the patent and pursuant to 37 C.F.R. § 1.97(i), be placed in the file of the captioned application.

The Commissioner is authorized to charge said fees to Daffer McDaniel, LLP deposit account number 50-3268/5887-00100.

Respectfully submitted,

A handwritten signature in black ink, appearing to read "Kevin L. Daffer", is written over the typed name.

Kevin L. Daffer
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Date: July 14, 2005

JUL 18 2005

Form PTO-1449 (modified)
List of Patents and Publications
For Applicant's Information
Disclosure Statement
(Use several sheets if necessary)

APP. DKT. NO. 5887-00100

APPLICANT: Opfermann et al.

FILING DATE: September 4, 2003

SERIAL NO. 10/654,780

GROUP: 2878

U.S. PATENT DOCUMENTS

EXAM. INITIALS	REF. DES.	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
		4,928,254	5/1990	Knudsen et al.			
		5,713,665	2/1998	Kato et al.			

FOREIGN PATENT DOCUMENTS

EXAM. INITIALS	REF. DES.	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS	TRANSLATION YES/NO
	A1	33 17 513	11/1984	DE			No
	A2	8-261967	10/1996	JP			Yes

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

	A3	Larson et al., "Correction for Finite-Pulse-Time Effects in Very Thin Samples using the Flash Method of Measuring Thermal Diffusivity," Journal of Applied Physics, Vol. 38, No. 2, 1967, pp. 465-474.
	A4	Cape et al., "Temperature and Finite-Pulse-Time Effects in the Flash Method for Measuring Thermal Diffusivity," Journal of Applied Physics, Vol. 34, No. 7, 1963, pp. 1909-1913.
	A5	Cowan, "Pulse Method of Measuring Thermal Diffusivity at High Temperatures," Journal of Applied Physics, Vol. 34, No. 4, Part 1, 1963, pp. 926-927.
	A6	Mehling et al., "Thermal Diffusivity of Semitransparent Materials Determined by the Laser-Flash Method Applying a New Analytical Model," International Journal of Thermophysics, Vol. 19, No. 3, 1998, pp. 941-949.

EXAMINER:

DATE CONSIDERED:

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the patent owner.